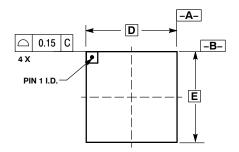
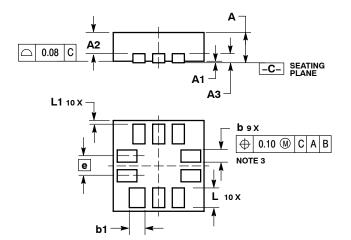


10 PIN QFN, 3x3 **CASE 501-02 ISSUE B**

DATE 11/20/2002

SCALE 4:1





- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: MILLIMETERS

 3. DIMENSION 5 APPLIES TO PLATED TERMINALS

 AND IS MEASURED BETWEEN 0.25 AND 0.30 MM
 FROM TERMINAL.
- COPLANAITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
 501-01 OBSOLETE, NEW STANDARD IS -02.

	MILLIMETERS		
DIM	MIN	MAX	
Α	0.800	1.000	
A1	0.000	0.050	
A2	0.600	0.800	
A3	0.203 REF		
D	3.00 BSC		
Е	3.00 BSC		
b	0.371	0.421	
b1	0.498	0.548	
е	0.650 BSC		
L	0.523	0.673	
L1	0.000	0.127	

MARKING DIAGRAM

• xxxx XXXX ALYW

XXXX = Specific Device Code = Assembly Location Α

= Wafer Lot L Υ = Year

W = Work Week

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